

TLVx171

低コスト・システム向けの36V、単一電源、低消費電力オペアンプ

1 特長

- 電源電圧範囲: 2.7V~36V、 $\pm 1.35V \sim \pm 18V$
- 低ノイズ: $16nV/\sqrt{Hz}$
- 低いオフセット・ドリフト: $\pm 1\mu V/^\circ C$ (標準値)
- 入力のRFIフィルタリングによりEMIを強化
- 入力範囲は負の電源電圧にも対応
- ユニティ・ゲインで安定: 200pF容量性負荷
- レール・ツー・レール出力
- ゲイン帯域幅: 3MHz
- 低い静止電流: アンプごとに525 μA
- 高いコモンモード除去: 105dB (標準値)
- 低いバイアス電流: 10pA

2 アプリケーション

- トランスデューサ
- 貨幣計数機
- AC/DCコンバータ
- パワー・モジュール
- インバータ
- 試験用機器
- バッテリー駆動計測器
- TFT-LCD駆動回路
- アクティブ・フィルタ

3 概要

36V TLVx171ファミリは、省コストが重要な産業用や個人用電子機器システム向けの低消費電力オペアンプ(op amp)で、電磁気干渉(EMI)耐性が高く、低ノイズで、2.7V ($\pm 1.35V$)~36 V ($\pm 18V$)の単一電源で動作します。1チャンネルのTLV171、2チャンネルのTLV2171、4チャンネルのTLV4171があり、消費電力制限の中で、低いオフセット、ドリフト係数、静止電流と、高い帯域幅との最適なバランスを実現しています。これらのデバイスは、容積の制限が厳しいシステム用にマイクロパッケージで供給され、仕様が同一なので、設計を最大に柔軟化できます。

ほとんどのオペアンプでは1つの電源電圧でしか動作が規定されていないのに対して、TLVx171ファミリは2.7V~36Vでの動作が規定されています。電源レールの範囲外の入力信号が位相反転を起こすことはありません。

TLVx171ファミリは、最大200pFの容量性負荷で安定です。通常の動作時に、入力は負のレールより100mV下、および上限レールの2V以内で動作できます。これらのデバイスは完全なレール・ツー・レール入力で、上限レールを100mV超えて動作し、上限レールの2V以内ではパフォーマンスが低下して動作します。

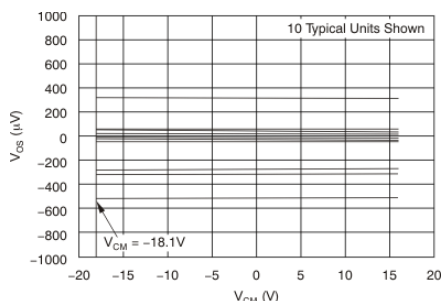
TLVx171オペアンプは、 $-40^\circ C \sim +125^\circ C$ での動作が規定されています。

製品情報⁽¹⁾

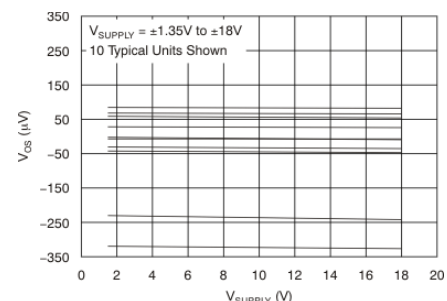
型番	パッケージ	本体サイズ(公称)
TLV171	SOIC (8)	4.90mm×3.91mm
	SOT-23 (5)	2.90mm×1.60mm
TLV2171	SOIC (8)	4.90mm×3.91mm
	VSSOP (8)	3.00mm×3.00mm
TLV4171	SOIC (14)	8.65mm×3.91mm
	TSSOP (14)	5.00mm×4.40mm

(1) 提供されているすべてのパッケージについては、データシートの末尾にある注文情報を参照してください。

オフセット電圧とコモンモード電圧との関係



オフセット電圧と電源電圧との関係



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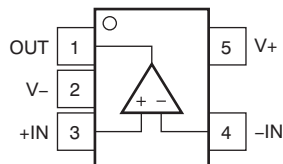
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4 改訂履歴

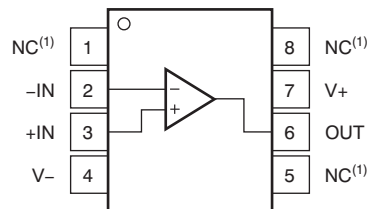
日付	改訂内容	注
2016年9月	*	初版

5 Pin Configuration and Functions

**TLV171: DBV Package
5-Pin SOT-23
Top View**



**TLV171: D Package
8-Pin SOIC
Top View**

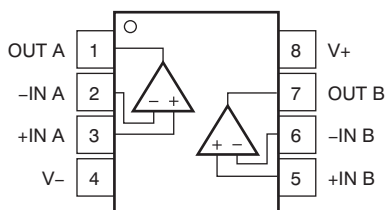


Pin Functions: TLV171

NAME	PIN		I/O	DESCRIPTION
	TLV171			
	DBV	D		
IN-	4	2	I	Negative (inverting) input
IN+	3	3	I	Positive (noninverting) input
NC ⁽¹⁾	—	1, 5, 8	—	No internal connection (can be left floating)
OUT	1	6	O	Output
V+	5	7	—	Positive (highest) power supply
V-	2	4	—	Negative (lowest) power supply

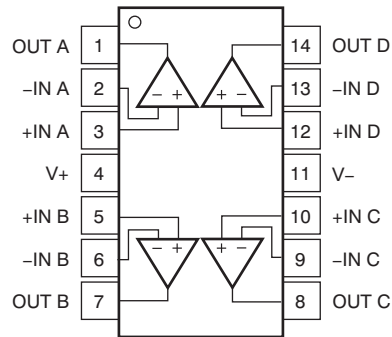
(1) NC indicates no internal connection.

**TLV2171: D and DGK Packages
8-Pin SOIC and VSSOP
Top View**



Pin Functions: TLV2171

NAME	PIN		I/O	DESCRIPTION
	TLV2171			
	D	DGK		
-IN A	2	2	I	Inverting input, channel A
-IN B	6	6	I	Inverting input, channel B
+IN A	3	3	I	Noninverting input, channel A
+IN B	5	5	I	Noninverting input, channel B
OUT A	1	1	O	Output, channel A
OUT B	7	7	O	Output, channel B
V-	4	4	—	Negative (lowest) power supply
V+	8	8	—	Positive (highest) power supply

**TLV4171: D and PW Packages
14-Pin SOIC and TSSOP
Top View**

Pin Functions: TLV4171

NAME	PIN		I/O	DESCRIPTION
	D	PW		
-IN A	2	2	I	Inverting input, channel A
+IN A	3	3	I	Noninverting input, channel A
-IN B	6	6	I	Inverting input, channel B
+IN B	5	5	I	Noninverting input, channel B
-IN C	9	9	I	Inverting input, channel C
+IN C	10	10	I	Noninverting input, channel C
-IN D	13	13	I	Inverting input, channel D
+IN D	12	12	I	Noninverting input, channel D
OUT A	1	1	O	Output, channel A
OUT B	7	7	O	Output, channel B
OUT C	8	8	O	Output, channel C
OUT D	14	14	O	Output, channel D
V-	11	11	—	Negative (lowest) power supply
V+	4	4	—	Positive (highest) power supply

6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range, unless otherwise noted.⁽¹⁾

		MIN	MAX	UNIT
Voltage	Supply voltage, V+ to V-	-20	20	V
	Signal input pin	(V-) - 0.5	(V+) + 0.5	
Current	Signal input pin	-10	10	mA
	Output short-circuit ⁽²⁾	Continuous		
Temperature	Operating, T _A	-55	150	°C
	Junction, T _J		150	
	Storage, T _{stg}	-65	150	

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Short-circuit to ground, one amplifier per package.

6.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±4000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±750

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltage (V+ - V-)	Single supply	2.7		36	V
	Dual supply	±1.35		±18	
Specified temperature		-40		+125	°C

6.4 Thermal Information: TLV171

THERMAL METRIC ⁽¹⁾		TLV171		UNIT
		D (SOIC)	DBV (SOT-23)	
		8 PINS	5 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	149.5	245.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	97.9	133.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	87.7	83.6	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	35.5	18.2	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	89.5	83.1	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	—	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Thermal Information: TLV2171

THERMAL METRIC ⁽¹⁾		TLV2171		UNIT
		D (SOIC)	DGK (VSSOP)	
		8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	134.3	175.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	72.1	74.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	60.6	22.2	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	18.2	1.6	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	53.8	22.8	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	—	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.6 Thermal Information: TLV4171

THERMAL METRIC ⁽¹⁾		TLV4171		UNIT
		D (SOIC)	PW (TSSOP)	
		14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	93.2	106.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	51.8	24.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	49.4	59.3	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	13.5	0.6	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	42.2	54.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	—	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.7 Electrical Characteristics

at $T_A = 25^\circ\text{C}$, $V_{CM} = V_{OUT} = V_S / 2$, and $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET VOLTAGE						
V_{OS}	Input offset voltage	$T_A = 25^\circ\text{C}$		0.75	± 2.7	mV
		$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$			± 3.0	
dV_{OS}/dT	Input offset voltage drift	$T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		1		$\mu\text{V}/^\circ\text{C}$
PSRR	Input offset voltage vs power supply	$V_S = 4\text{ V}$ to 36 V , $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	90	105		dB
INPUT BIAS CURRENT						
I_B	Input bias current			± 10		pA
I_{OS}	Input offset current			± 4		pA
NOISE						
	Input voltage noise	$f = 0.1\text{ Hz}$ to 10 Hz		3		μV_{PP}
e_n	Input voltage noise density	$f = 100\text{ Hz}$		27		$\text{nV}/\sqrt{\text{Hz}}$
		$f = 1\text{ kHz}$		16		
INPUT VOLTAGE						
V_{CM}	Common-mode voltage range ⁽¹⁾		$(V_-) - 0.1$		$(V_+) - 2$	V
CMRR	Common-mode rejection ratio	$V_S = \pm 18\text{ V}$, $(V_-) - 0.1\text{ V} < V_{CM} < (V_+) - 2\text{ V}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	94	105		dB
INPUT IMPEDANCE						
	Differential			$100 \parallel 3$		$\text{M}\Omega \parallel \text{pF}$
	Common-mode			$6 \parallel 3$		$10^{12}\ \Omega \parallel \text{pF}$
OPEN-LOOP GAIN						
A_{OL}	Open-loop voltage gain	$V_S = 36\text{ V}$, $(V_-) + 0.35\text{ V} < V_O < (V_+) - 0.35\text{ V}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	94	130		dB
FREQUENCY RESPONSE						
GBP	Gain bandwidth product			3.0		MHz
SR	Slew rate	$G = +1$		1.5		$\text{V}/\mu\text{s}$
t_s	Settling time	To 0.1%, $V_S = \pm 18\text{ V}$, $G = +1$, 10-V step		6		μs
		To 0.01% (12 bits), $V_S = \pm 18\text{ V}$, $G = +1$, 10-V step		10		
	Overload recovery time	$V_{IN} \times \text{gain} > V_S$		2		μs
THD+N	Total harmonic distortion + noise	$G = +1$, $f = 1\text{ kHz}$, $V_O = 3\text{ V}_{RMS}$		0.0002%		

(1) The input range can be extended beyond $(V_+) - 2\text{ V}$ up to V_+ . See the [Typical Characteristics](#) and [Application and Implementation](#) sections for additional information.

Electrical Characteristics (continued)

 at $T_A = 25^\circ\text{C}$, $V_{CM} = V_{OUT} = V_S / 2$, and $R_L = 10\text{ k}\Omega$ connected to $V_S / 2$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OUTPUT						
V_O	Voltage output swing	Positive rail, $V_S = \pm 18\text{ V}$, $R_L = 10\text{ k}\Omega$, $T_A = 25^\circ\text{C}$		160		mV
		Negative rail, $V_S = \pm 18\text{ V}$, $R_L = 10\text{ k}\Omega$, $T_A = 25^\circ\text{C}$		90		mV
		$R_L = 10\text{ k}\Omega$, $A_{OL} \geq 94\text{ dB}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$	(V-) + 0.35		(V+) – 0.35	V
I_{SC}	Short-circuit current		25		mA	
			–35			
C_{LOAD}	Capacitive load drive	See Typical Characteristics			pF	
R_O	Open-loop output resistance	$f = 1\text{ MHz}$, $I_O = 0\text{ A}$		150	Ω	
POWER SUPPLY						
V_S	Specified voltage range		2.7	36	V	
I_Q	Quiescent current per amplifier	$I_O = 0\text{ A}$, $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$		525	695	μA
TEMPERATURE						
	Specified range		–40	125	$^\circ\text{C}$	
	Operating range		–55	150	$^\circ\text{C}$	

6.8 Typical Characteristics

at $V_S = \pm 18\text{ V}$, $V_{CM} = V_S / 2$, $R_{LOAD} = 10\text{ k}\Omega$ connected to $V_S / 2$, and $C_L = 100\text{ pF}$ (unless otherwise noted)

Table 1. Characteristic Performance Measurements

DESCRIPTION	FIGURE
Offset Voltage Production Distribution	Figure 1
Offset Voltage vs Common-Mode Voltage	Figure 2
Offset Voltage vs Common-Mode Voltage (Upper Stage)	Figure 3
Input Bias Current and Input Offset Current vs Temperature	Figure 4
Output Voltage Swing vs Output Current (Maximum Supply)	Figure 5
CMRR and PSRR vs Frequency (Referred-to-Input)	Figure 6
0.1-Hz to 10-Hz Noise	Figure 7
Input Voltage Noise Spectral Density vs Frequency	Figure 8
Quiescent Current vs Supply Voltage	Figure 9
Open-Loop Gain and Phase vs Frequency	Figure 10
Closed-Loop Gain vs Frequency	Figure 11
Open-Loop Gain vs Temperature	Figure 12
Open-Loop Output Impedance vs Frequency	Figure 13
Small-Signal Overshoot vs Capacitive Load	Figure 14 , Figure 15
No Phase Reversal	Figure 16
Small-Signal Step Response (100 mV)	Figure 17 , Figure 18
Large-Signal Step Response	Figure 19 , Figure 20
Large-Signal Settling Time (10-V Positive Step)	Figure 21
Large-Signal Settling Time (10-V Negative Step)	Figure 22
Short-Circuit Current vs Temperature	Figure 23
Maximum Output Voltage vs Frequency	Figure 24
EMIRR IN+ vs Frequency	Figure 25

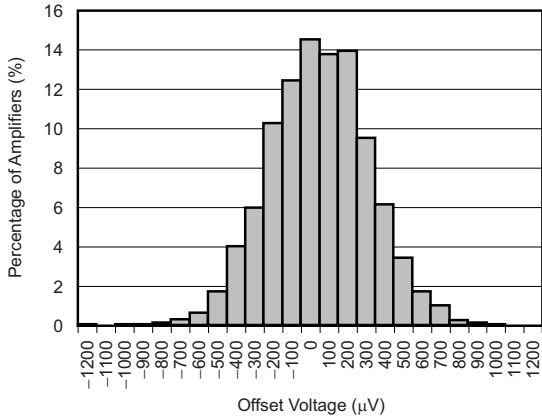


Figure 1. Offset Voltage Production Distribution

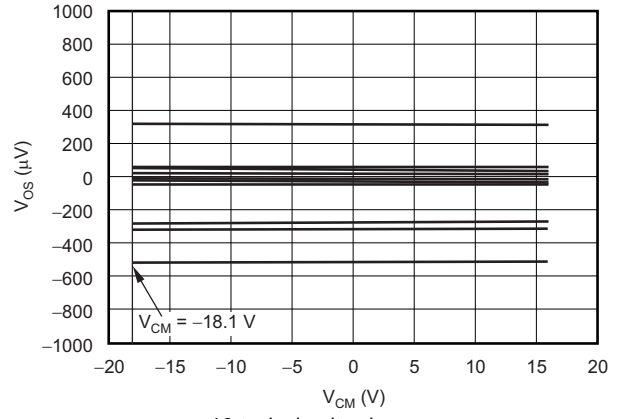


Figure 2. Offset Voltage vs Common-Mode Voltage

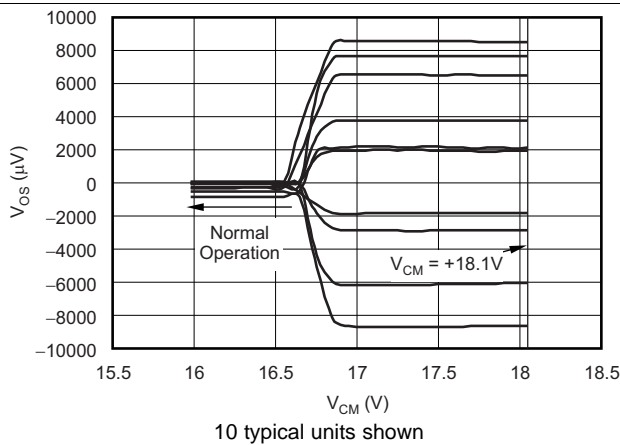


Figure 3. Offset Voltage vs Common-Mode Voltage (Upper Stage)

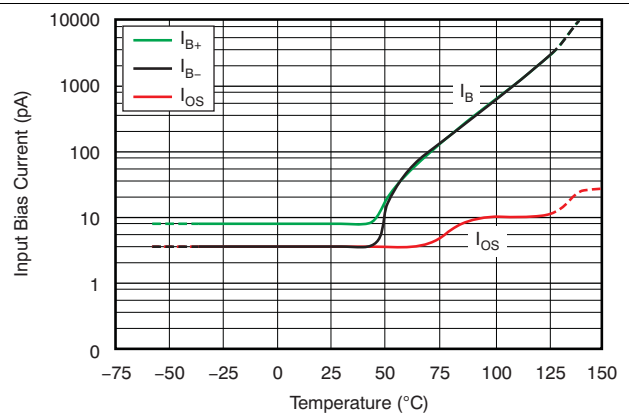


Figure 4. Input Bias Current and Input Offset Current vs Temperature

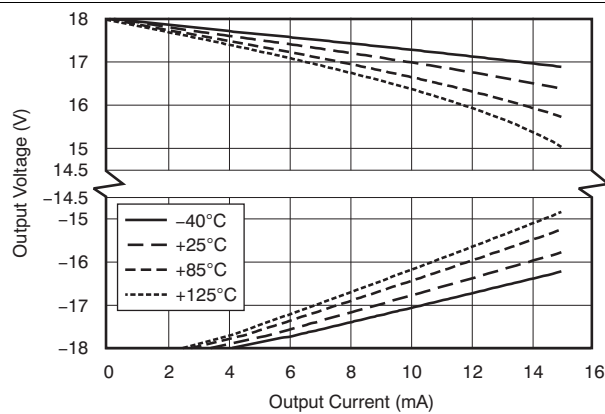


Figure 5. Output Voltage Swing vs Output Current (Maximum Supply)

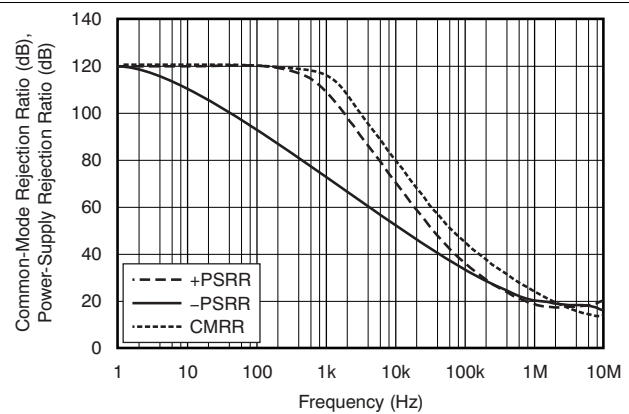


Figure 6. CMRR and PSRR vs Frequency (Referred-to Input)

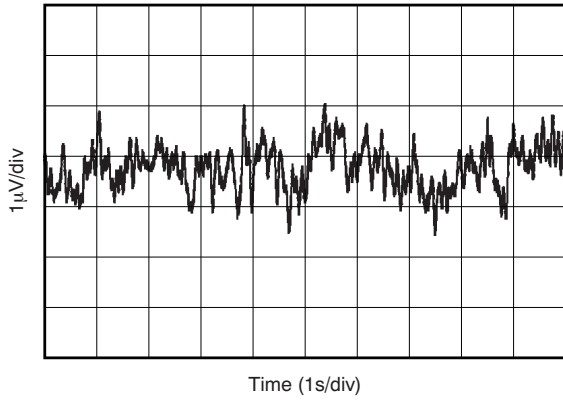


Figure 7. 0.1-Hz to 10-Hz Noise

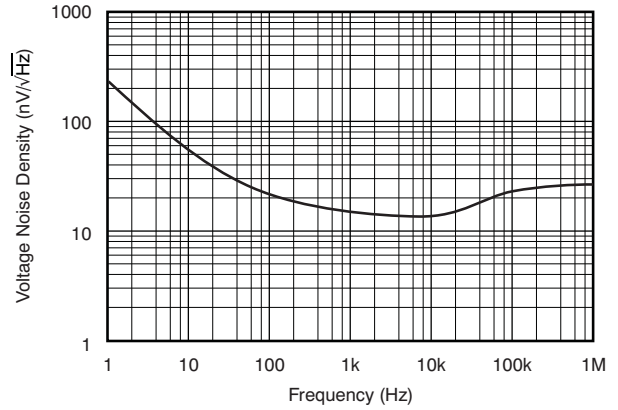


Figure 8. Input Voltage Noise Spectral Density vs Frequency

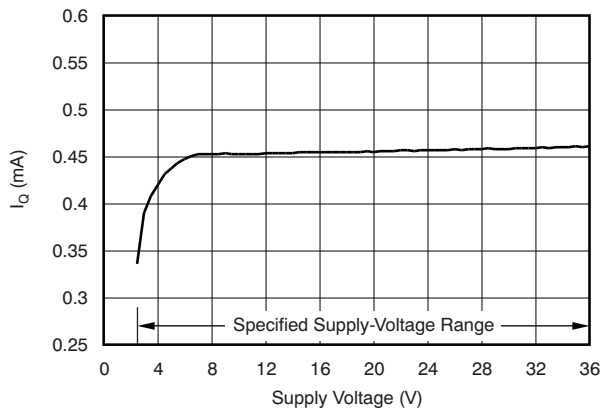


Figure 9. Quiescent Current vs Supply Voltage

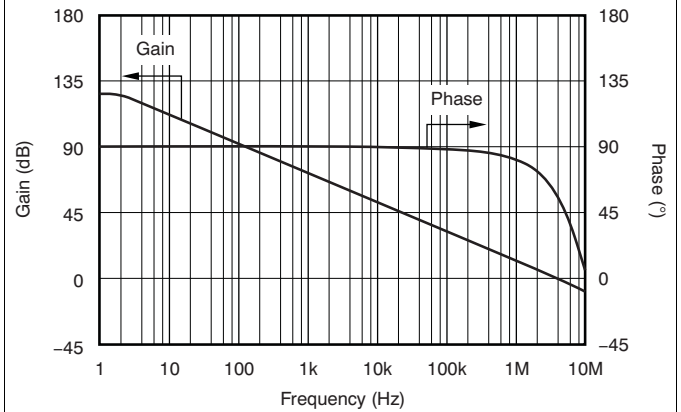


Figure 10. Open-Loop Gain and Phase vs Frequency

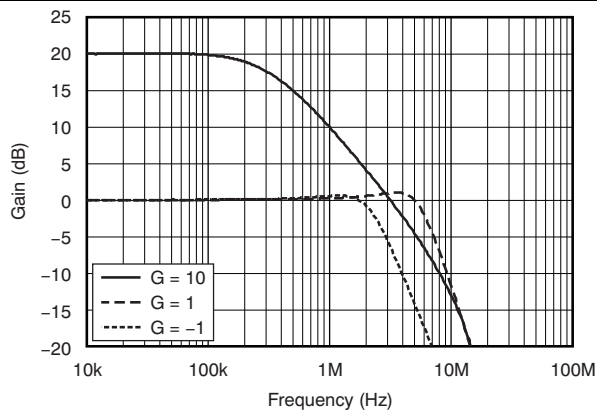


Figure 11. Closed-Loop Gain vs Frequency

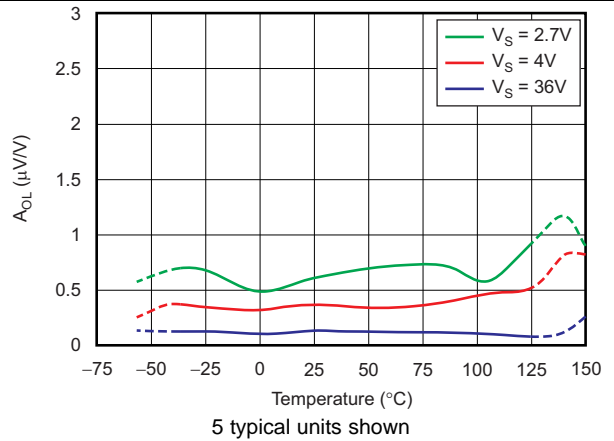


Figure 12. Open-Loop Gain vs Temperature

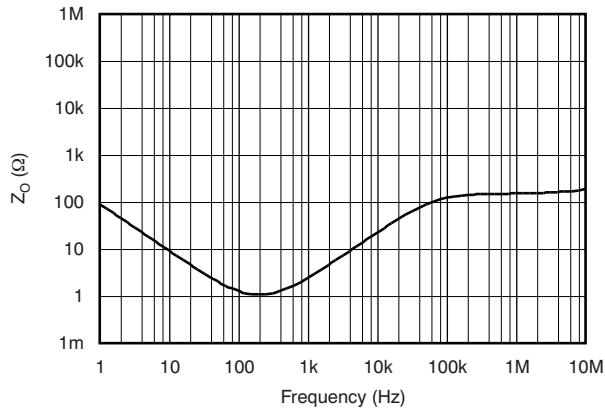


Figure 13. Open-Loop Output Impedance vs Frequency

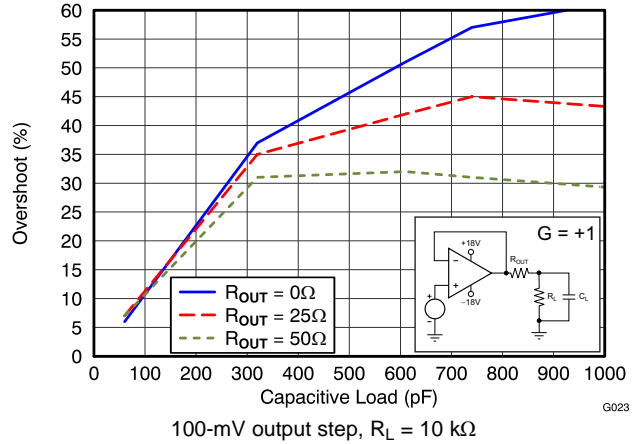


Figure 14. Small-Signal Overshoot vs Capacitive Load

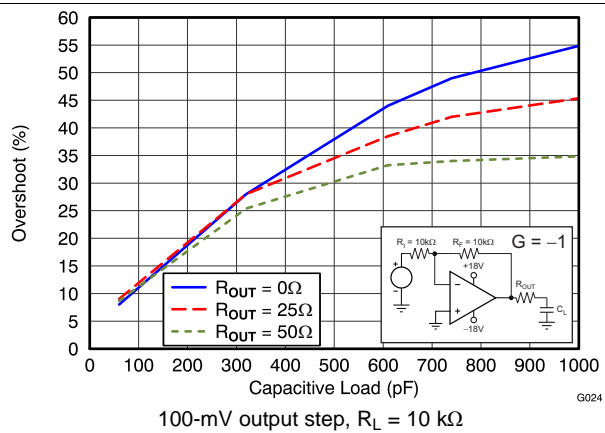


Figure 15. Small-Signal Overshoot vs Capacitive Load

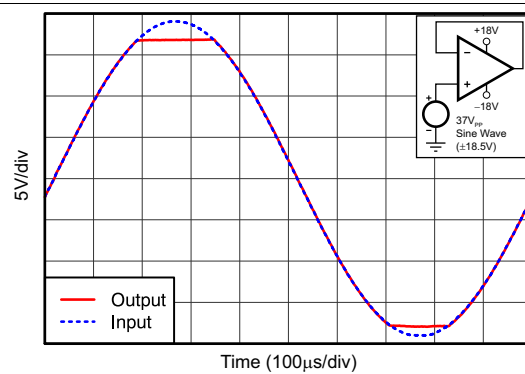


Figure 16. No Phase Reversal

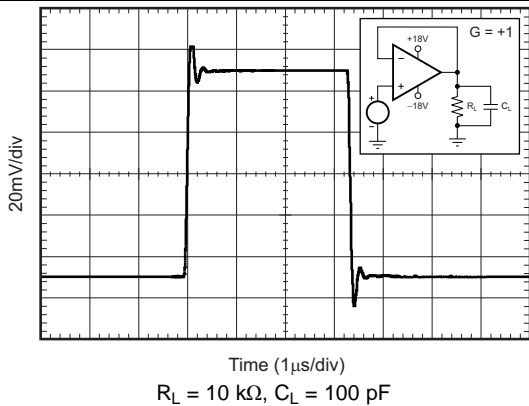


Figure 17. Small-Signal Step Response (100 mV)

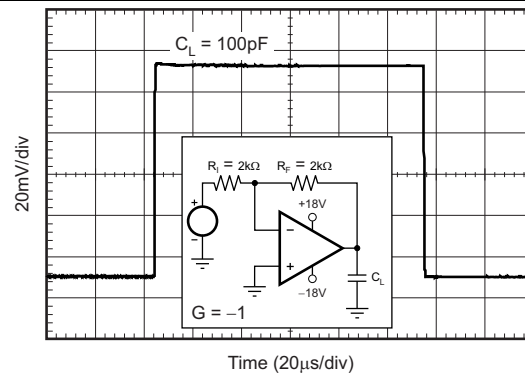
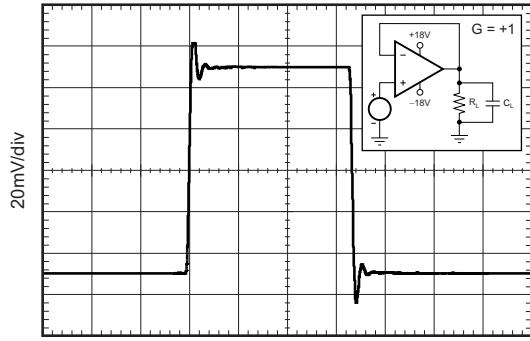
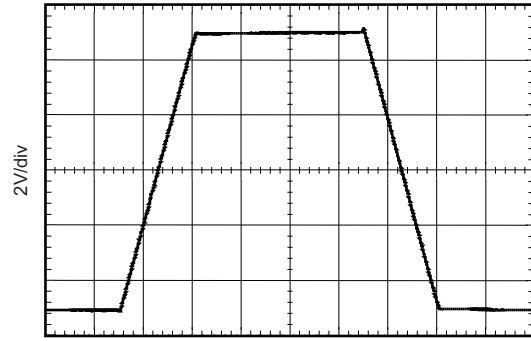


Figure 18. Small-Signal Step Response (100 mV)



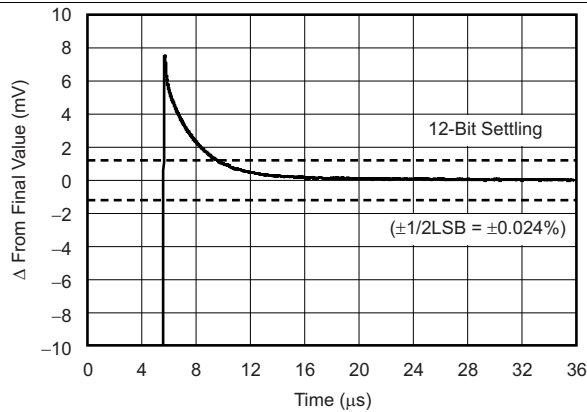
Time (1µs/div)
G = +1, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$

Figure 19. Large-Signal Step Response



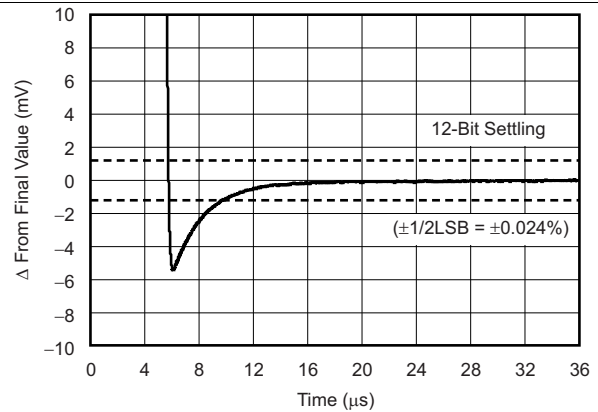
Time (4µs/div)
G = -1, $R_L = 10\text{ k}\Omega$, $C_L = 100\text{ pF}$

Figure 20. Large-Signal Step Response



10-V positive step, G = -1

Figure 21. Large-Signal Settling Time



10-V negative step, G = -1

Figure 22. Large-Signal Settling Time

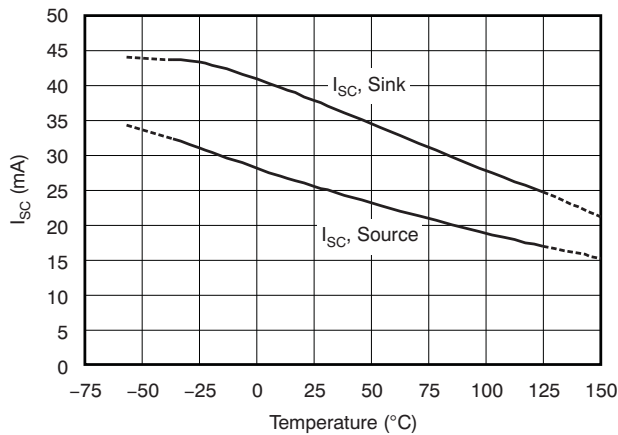


Figure 23. Short-Circuit Current vs Temperature

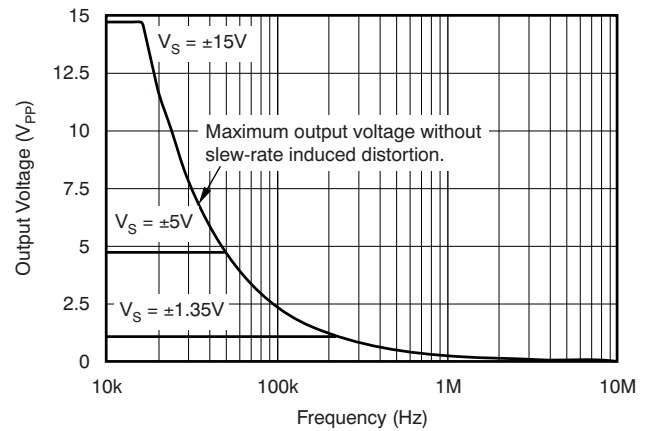


Figure 24. Maximum Output Voltage vs Frequency

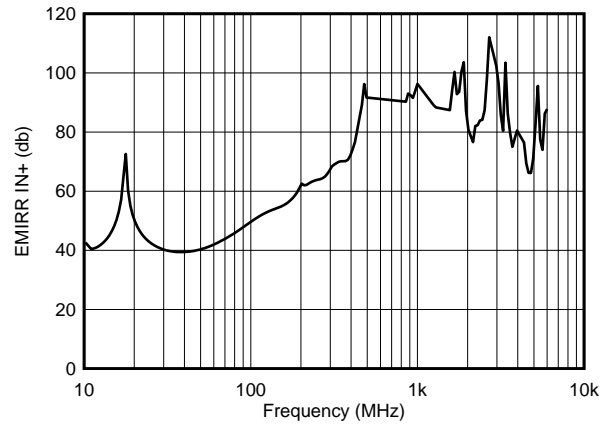


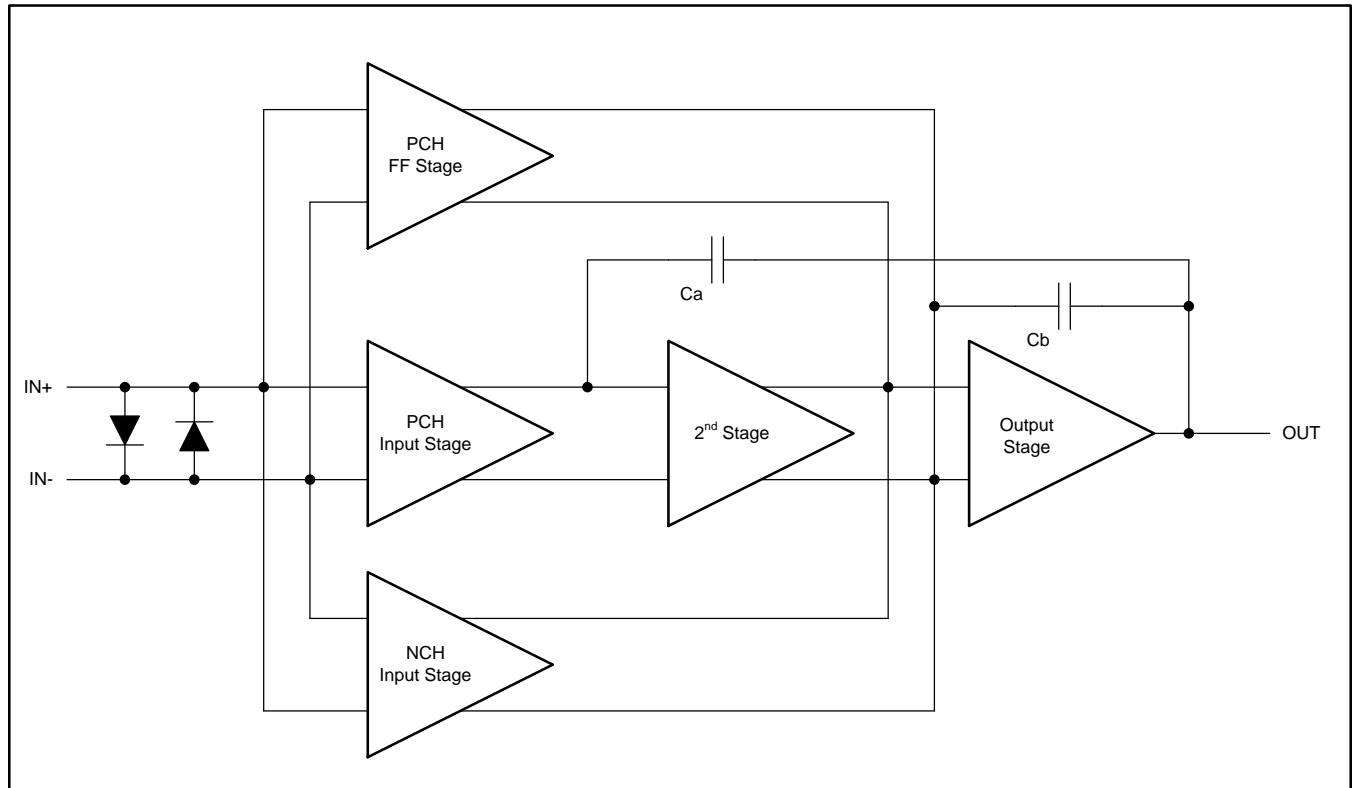
Figure 25. EMIRR IN+ vs Frequency

7 Detailed Description

7.1 Overview

The TLVx171 family of operational amplifiers provides high overall performance, making these devices ideal for many general-purpose applications. The excellent offset drift of only $2 \mu\text{V}/^\circ\text{C}$ provides excellent stability over the entire temperature range. In addition, the device family offers very good overall performance with high common-mode rejection ratio (CMRR), power-supply rejection ratio (PSRR), and open-loop voltage gain (A_{OL}).

7.2 Functional Block Diagram



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7.3 Feature Description

7.3.1 Operating Characteristics

The TLVx171 family of amplifiers is specified for operation from 2.7 V to 36 V, single supply ($\pm 1.35 \text{ V}$ to $\pm 18 \text{ V}$, dual supply). Many of the specifications apply from -40°C to $+125^\circ\text{C}$. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#) section.

Feature Description (continued)

7.3.2 Phase-Reversal Protection

The TLVx171 family has an internal phase-reversal protection. Many operational amplifiers exhibit a phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The input of the TLVx171 prevents phase reversal with excessive common-mode voltage. Instead, the output limits into the appropriate rail. This performance is shown in [Figure 26](#).

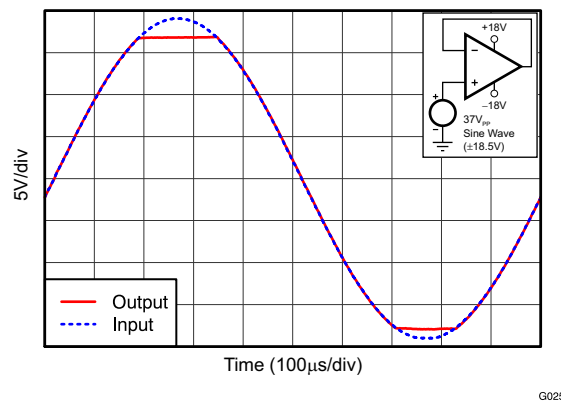


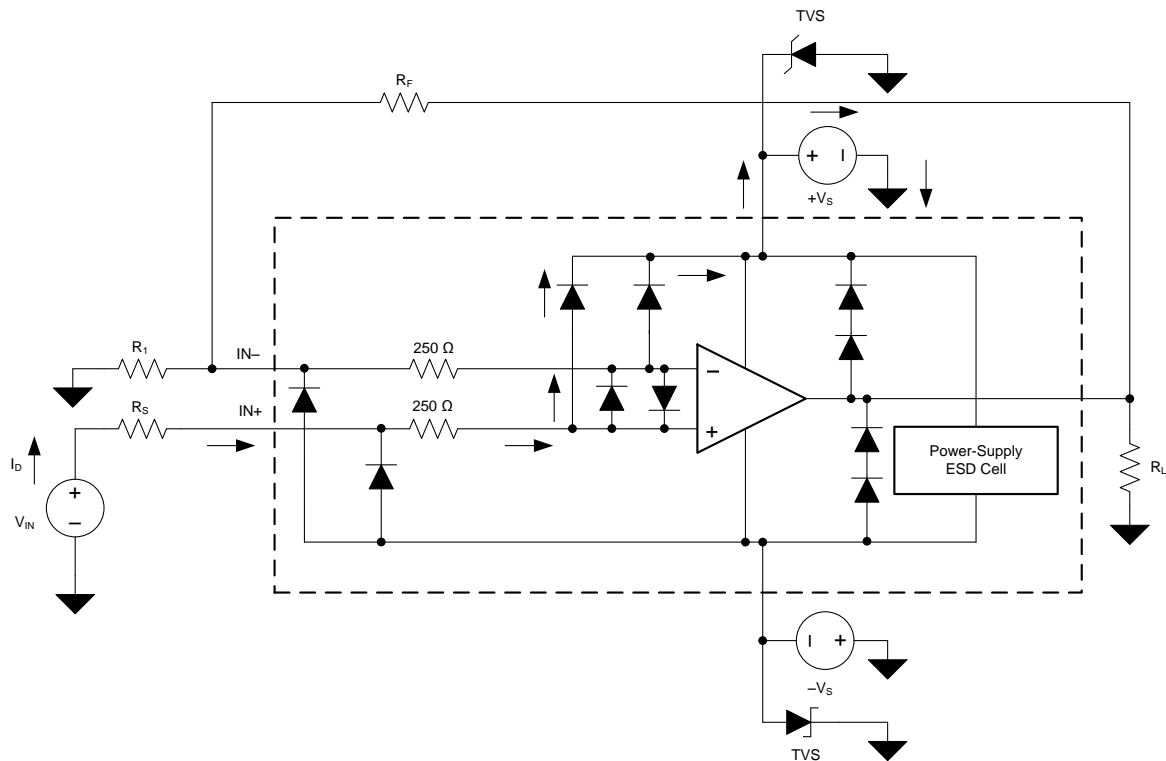
Figure 26. No Phase Reversal

7.3.3 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits for protection from accidental ESD events both before and during product assembly.

A good understanding of this basic ESD circuitry and the relevance to an electrical overstress event is helpful. [Figure 27](#) illustrates the ESD circuits contained in the TLVx171 (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

Feature Description (continued)



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Figure 27. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application

An ESD event produces a short-duration, high-voltage pulse that is transformed into a short-duration, high-current pulse when discharging through a semiconductor device. The ESD protection circuits are designed to provide a current path around the operational amplifier core to prevent damage. The energy absorbed by the protection circuitry is then dissipated as heat.

When an ESD voltage develops across two or more amplifier device pins, current flows through one or more steering diodes. Depending on the path that the current takes, the absorption device can activate. The absorption device has a trigger, or threshold voltage, that is above the normal operating voltage of the TLVx171 but below the device breakdown voltage level. When this threshold is exceeded, the absorption device quickly activates and clamps the voltage across the supply rails to a safe level.

When the operational amplifier connects into a circuit (as shown in Figure 27), the ESD protection components are intended to remain inactive and do not become involved in the application circuit operation. However, circumstances may arise where an applied voltage exceeds the operating voltage range of a given pin. If this condition occurs, there is a risk that some internal ESD protection circuits can turn on and conduct current. Any such current flow occurs through steering-diode paths and rarely involves the absorption device.

Figure 27 shows a specific example where the input voltage (V_{IN}) exceeds the positive supply voltage ($V+$) by 500 mV or more. Much of what happens in the circuit depends on the supply characteristics. If $V+$ can sink the current, one of the upper input steering diodes conducts and directs current to $V+$. Excessively high current levels can flow with increasingly higher V_{IN} . As a result, the data sheet specifications recommend that applications limit the input current to 10 mA.

If the supply is not capable of sinking the current, V_{IN} can begin sourcing current to the operational amplifier and then take over as the source of positive supply voltage. The danger in this case is that the voltage can rise to levels that exceed the operational amplifier absolute maximum ratings.

Feature Description (continued)

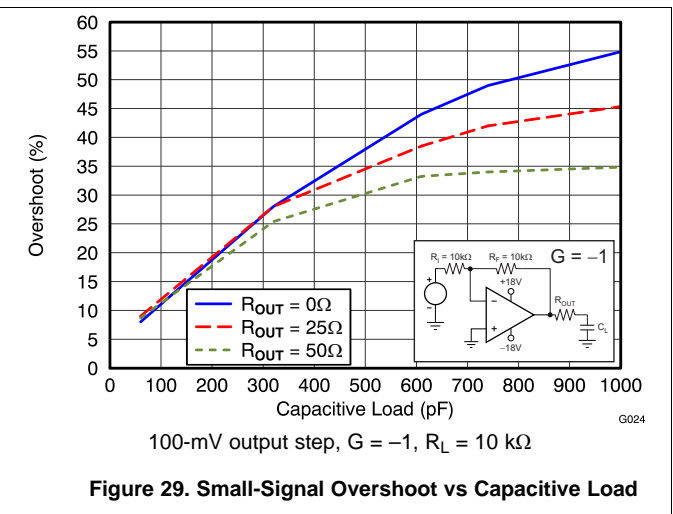
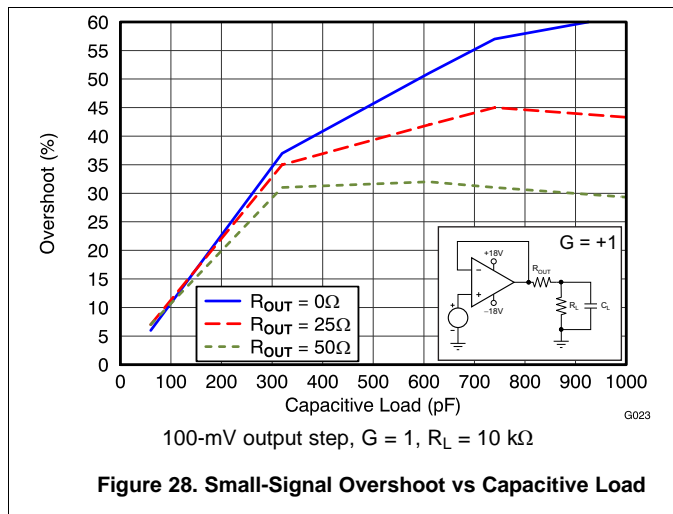
Another common question involves what happens to the amplifier if an input signal is applied to the input when the power supplies ($V+$ or $V-$) are at 0 V. Again, this question depends on the supply characteristic when at 0 V, or at a level below the input signal amplitude. If the supplies appear as high impedance, then the input source supplies the operational amplifier current through the current-steering diodes. This state is not a normal bias condition; most likely, the amplifier does not operate normally. If the supplies are low impedance, then the current through the steering diodes can become quite high. The current level depends on the ability of the input source to deliver current, and any resistance in the input path.

If there is any uncertainty about the ability of the supply to absorb this current, add external Zener diodes to the supply pins; see [Figure 27](#). Select the Zener voltage so that the diode does not turn on during normal operation. However, the Zener voltage must be low enough so that the Zener diode conducts if the supply pin begins to rise above the safe-operating, supply-voltage level.

The TLVx171 input pins are protected from excessive differential voltage with back-to-back diodes; see [Figure 27](#). In most circuit applications, the input protection circuitry has no effect. However, in low-gain or $G = 1$ circuits, fast-ramping input signals can forward-bias these diodes because the output of the amplifier cannot respond rapidly enough to the input ramp. If the input signal is fast enough to create this forward-bias condition, limit the input signal current to 10 mA or less. If the input signal current is not inherently limited, an input series resistor can be used to limit the input signal current. This input series resistor degrades the low-noise performance of the TLVx171. [Figure 27](#) illustrates an example configuration that implements a current-limiting feedback resistor.

7.3.4 Capacitive Load and Stability

The dynamic characteristics of the TLVx171 are optimized for common operating conditions. The combination of low closed-loop gain and high capacitive loads decreases the phase margin of the amplifier and can lead to gain peaking or oscillations. As a result, heavier capacitive loads must be isolated from the output. The simplest way to achieve this isolation is to add a small resistor (for example, R_{OUT} equal to 50 Ω) in series with the output. [Figure 28](#) and [Figure 29](#) show graphs of small-signal overshoot versus capacitive load for several values of R_{OUT} . Also, see applications bulletin AB-028, [Feedback Plots Define Op Amp AC Performance](#) for details of analysis techniques and application circuits.



7.4 Device Functional Modes

7.4.1 Common-Mode Voltage Range

The input common-mode voltage range of the TLVx171 family extends 100 mV below the negative rail and within 2 V of the top rail for normal operation.

This device family can operate with a full rail-to-rail input 100 mV beyond the top rail, but with reduced performance within 2 V of the top rail.

7.4.2 Overload Recovery

Overload recovery is defined as the time required for the operational amplifier output to recover from the saturated state to the linear state. The output devices of the operational amplifier enter the saturation region when the output voltage exceeds the rated operating voltage, either resulting from the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices need time to return back to the normal state. After the charge carriers return back to the equilibrium state, the device begins to slew at the normal slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time. The overload recovery time for the TLVx171 is approximately 2 μ s.

8 Application and Implementation

NOTE

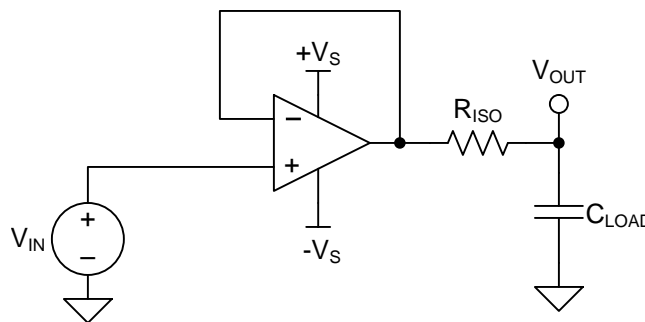
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The TLVx171 family of operational amplifiers provides high overall performance in a large number of general-purpose applications. As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors placed close to the device pins. In most cases, 0.1- μ F capacitors are adequate. Follow the additional recommendations in the [Layout Guidelines](#) section in order to achieve the maximum performance from this device. Many applications can introduce capacitive loading to the output of the amplifier (potentially causing instability). One method of stabilizing the amplifier in such applications is to add an isolation resistor between the amplifier output and the capacitive load. The design process for selecting this resistor is given in the [Typical Application](#) section.

8.2 Typical Application

This circuit can be used to drive capacitive loads such as cable shields, reference buffers, MOSFET gates, and diodes. The circuit uses an isolation resistor (R_{ISO}) to stabilize the output of an operational amplifier. R_{ISO} modifies the open-loop gain of the system to ensure that the circuit has sufficient phase margin.



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Figure 30. Unity-Gain Buffer With R_{ISO} Stability Compensation

8.2.1 Design Requirements

The design requirements are:

- Supply voltage: 30 V (± 15 V)
- Capacitive loads: 100 pF, 1000 pF, 0.01 μ F, 0.1 μ F, and 1 μ F
- Phase margin: 45° and 60°

8.2.2 Detailed Design Procedure

[Figure 30](#) shows a unity-gain buffer driving a capacitive load. [Equation 1](#) shows the transfer function for the circuit in [Figure 30](#). Not shown in [Figure 30](#) is the open-loop output resistance of the operational amplifier, R_O .

$$T(s) = \frac{1 + C_{LOAD} \times R_{ISO} \times s}{1 + (R_O + R_{ISO}) \times C_{LOAD} \times s} \quad (1)$$

The transfer function in [Equation 1](#) has a pole and a zero. The frequency of the pole (f_p) is determined by $(R_O + R_{ISO})$ and C_{LOAD} . Components R_{ISO} and C_{LOAD} determine the frequency of the zero (f_z). A stable system is obtained by selecting R_{ISO} such that the rate of closure (ROC) between the open-loop gain (A_{OL}) and $1/\beta$ is 20 dB/decade. [Figure 31](#) illustrates this concept. The $1/\beta$ curve for a unity-gain buffer is 0 dB.

Typical Application (continued)

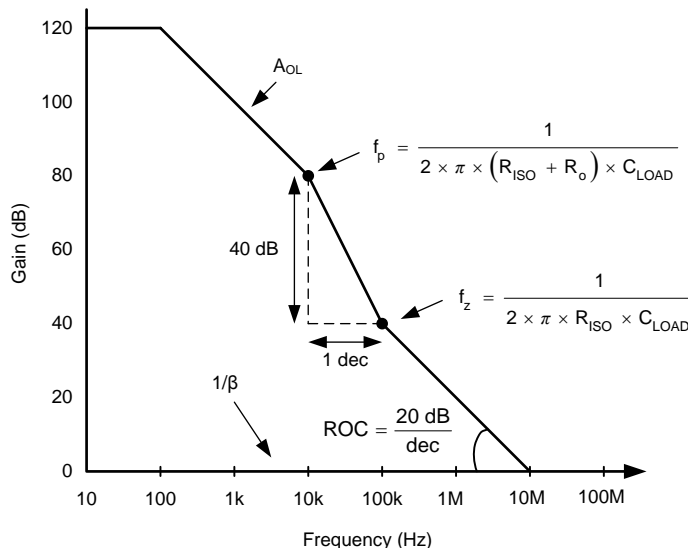


Figure 31. Unity-Gain Amplifier With R_{ISO} Compensation

ROC stability analysis is typically simulated. The validity of the analysis depends on multiple factors, especially the accurate modeling of R_O. In addition to simulating the ROC, a robust stability analysis includes a measurement of overshoot percentage and ac gain peaking of the circuit using a function generator, oscilloscope, and gain and phase analyzer. Phase margin is then calculated from these measurements. Table 2 shows the overshoot percentage and ac gain peaking that correspond to phase margins of 45° and 60°. For more details on this design and other alternative devices that can be used in place of the TLV171, see the Precision Design, [Capacitive Load Drive Solution Using an Isolation Resistor](#).

Table 2. Phase Margin versus Overshoot and AC Gain Peaking

PHASE MARGIN	OVERSHOOT	AC GAIN PEAKING
45°	23.3%	2.35 dB
60°	8.8%	0.28 dB

8.2.3 Application Curve

Using the described methodology, the values of R_{ISO} that yield phase margins of 45° and 60° for various capacitive loads were determined. The results are shown in Figure 32.

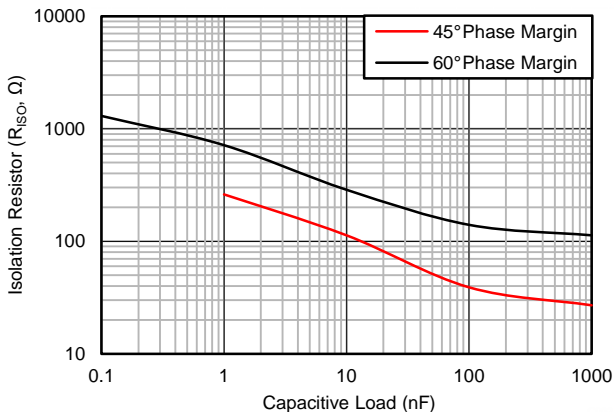


Figure 32. Isolation Resistor Required for Various Capacitive Loads to Achieve a Target Phase Margin

9 Power Supply Recommendations

The TLVx171 is specified for operation from 2.7 V to 36 V (± 1.35 V to ± 18 V); many specifications apply from -40°C to $+85^{\circ}\text{C}$. Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#) section.

CAUTION

Supply voltages larger than 40 V can permanently damage the device; see the [Absolute Maximum Ratings](#) table.

Place 0.1- μF bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, see the [Layout](#) section.

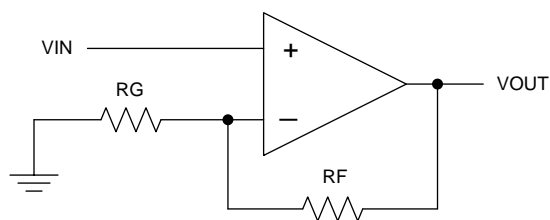
10 Layout

10.1 Layout Guidelines

For best operational performance of the device, use good printed-circuit board (PCB) layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and the operational amplifier itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1- μF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds, paying attention to the flow of the ground current.
- In order to reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicularly is much better than in parallel with the noisy trace.
- Place the external components as close to the device as possible. As illustrated in [Figure 34](#), keeping R_F and R_G close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.

10.2 Layout Example



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Figure 33. Schematic Representation

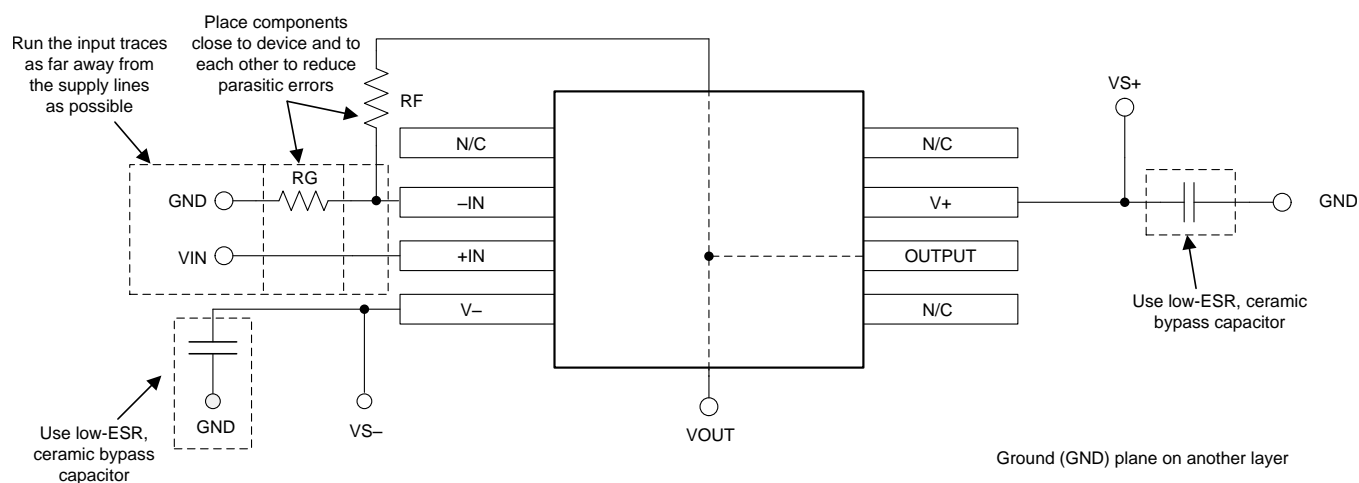


Figure 34. Operational Amplifier Board Layout for a Noninverting Configuration

11 デバイスおよびドキュメントのサポート

11.1 デバイス・サポート

11.1.1 開発サポート

11.1.1.1 TINA-TI™ (無料のダウンロード・ソフトウェア)

TINA™は、SPICEエンジンをベースにした単純かつ強力な、使いやすい回路シミュレーション・プログラムです。また、TINA-TI™はTINAソフトウェアの無料バージョンで、完全な機能を持ち、パッシブとアクティブ両方のモデルに加えて、マクロ・モデルのライブラリがプリロードされています。TINA-TI™には従来型のDC、過渡、および周波数ドメインのSPICEによる分析と、追加の設計機能が搭載されています。

TINA-TI™はAnalog eLab Design Centerから無料でダウンロードでき、ユーザーが結果をさまざまな方法でフォーマットできる、広範な後処理機能を備えています。仮想計測器により、入力波形を選択し、回路ノード、電圧、および波形をプローブして、動的なクイック・スタート・ツールを作成できます。

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11.1.1.2 DIPアダプタ評価モジュール

DIPアダプタ評価モジュール・ツールを使用すると、小さな表面実装デバイスのプロトタイプを簡単に、低コストで作成できます。この評価ツールは、DまたはU(SOIC-8)、PW(TSSOP-8)、DGK(VSSOP-8)、DBV(SOT23-6、SOT23-5、およびSOT23-3)、DCK(SC70-6およびSC70-5)、およびDRL(SOT563-6)のTIパッケージに対応しています。DIPアダプタ評価モジュールは、ターミナル・ストリップとともに使用することも、既存の回路へ直接接続することもできます。

11.1.1.3 ユニバーサル・オペアンプ評価モジュール

ユニバーサル・オペアンプ評価モジュールは一連の汎用のブランクアウト回路基板で、各種のデバイス・パッケージ・タイプ向け回路のプロトタイプ作成を容易にします。この評価モジュール基板は、多くの異なる回路を簡単かつ迅速に構築できるように設計されています。5つのモデルが提供されており、それぞれのモデルは特定のパッケージ・タイプを対象としています。PDIP、SOIC、MSOP、TSSOP、およびSOT23のパッケージがすべてサポートされています。

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11.1.1.4 TI Precision Designs

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11.1.1.5 WEBENCH® Filter Designer

WEBENCH® Filter Designerは単純で強力な、使いやすいアクティブ・フィルタ設計プログラムです。WEBENCH® Filter Designerにより、TIのオペアンプと、TIのベンダ・パートナーのパッシブ・コンポーネントを選択して、最適化されたフィルタを設計できます。

WEBENCH® Filter Designerは、WEBENCH® Design CenterからWebベースのツールとして利用でき、完全な多段アクティブ・フィルタ・ソリューションの設計、最適化、シミュレーションを、わずか数分で実行できます。

11.2 ドキュメントのサポート

11.2.1 関連資料

関連資料については、以下を参照してください:

『フィードバック・プロットによるオペアンプAC性能の定義』アプリケーション広報(SBOA015)

11.3 関連リンク

表 3 に、クイック・アクセス・リンクの一覧を示します。カテゴリには、技術資料、サポートおよびコミュニティ・リソース、ツールとソフトウェア、およびサンプル注文またはご購入へのクイック・アクセスが含まれます。

表 3. 関連リンク

製品	プロダクト・フォルダ	サンプルとご購入	技術資料	ツールとソフトウェア	サポートとコミュニティ
TLV171	ここをクリック	ここをクリック	ここをクリック	ここをクリック	ここをクリック
TLV2171	ここをクリック	ここをクリック	ここをクリック	ここをクリック	ここをクリック
TLV4171	ここをクリック	ここをクリック	ここをクリック	ここをクリック	ここをクリック

11.4 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、ti.comのデバイス製品フォルダを開いてください。右上の隅にある「通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

11.5 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

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11.8 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。これらの情報は、指定のデバイスに対して提供されている最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLV171IDBVR	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU SN	Level-2-260C-1 YEAR	-40 to 125	14RT
TLV171IDBVR.A	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	14RT
TLV171IDBVRG4	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	14RT
TLV171IDBVRG4.A	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	14RT
TLV171IDBVT	Active	Production	SOT-23 (DBV) 5	250 SMALL T&R	Yes	NIPDAU SN	Level-2-260C-1 YEAR	-40 to 125	14RT
TLV171IDBVT.A	Active	Production	SOT-23 (DBV) 5	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	14RT
TLV171IDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV171
TLV171IDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV171
TLV2171IDGKR	Active	Production	VSSOP (DGK) 8	2500 LARGE T&R	Yes	NIPDAU SN NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	14OV
TLV2171IDGKR.A	Active	Production	VSSOP (DGK) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	14OV
TLV2171IDGKT	Active	Production	VSSOP (DGK) 8	250 SMALL T&R	Yes	NIPDAU SN NIPDAUAG	Level-2-260C-1 YEAR	-40 to 125	14OV
TLV2171IDGKT.A	Active	Production	VSSOP (DGK) 8	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	14OV
TLV2171IDGKTG4	Active	Production	VSSOP (DGK) 8	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	14OV
TLV2171IDGKTG4.A	Active	Production	VSSOP (DGK) 8	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	14OV
TLV2171IDR	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TL2171
TLV2171IDR.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TL2171
TLV4171ID	Active	Production	SOIC (D) 14	50 TUBE	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4171
TLV4171ID.A	Active	Production	SOIC (D) 14	50 TUBE	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4171
TLV4171IDR	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4171
TLV4171IDR.A	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4171
TLV4171IDRG4	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4171
TLV4171IDRG4.A	Active	Production	SOIC (D) 14	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TLV4171
TLV4171IPWR	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV4171
TLV4171IPWR.A	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV4171
TLV4171IPWRG4	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV4171
TLV4171IPWRG4.A	Active	Production	TSSOP (PW) 14	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLV4171

(1) **Status:** For more details on status, see our [product life cycle](#).

- (2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.
- (3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.
- (4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF TLV171 :

- Automotive : [TLV171-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

EXAMPLE BOARD LAYOUT

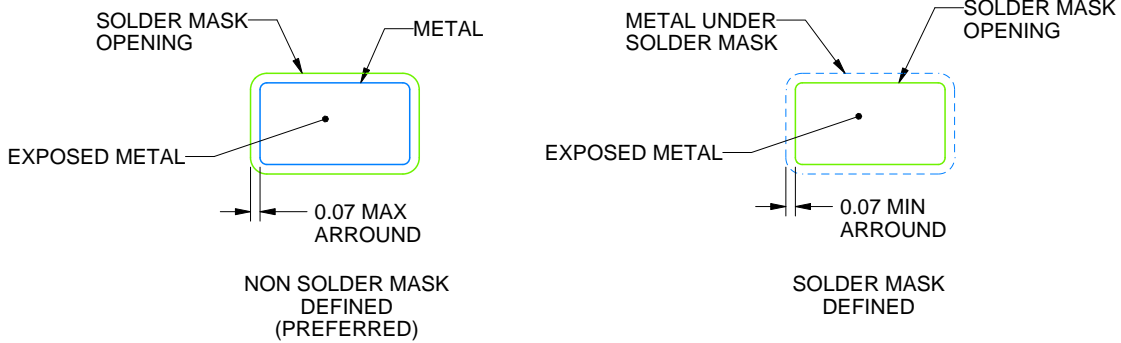
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/K 08/2024

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

4214839/K 08/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

DGK0008A



PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

EXAMPLE BOARD LAYOUT

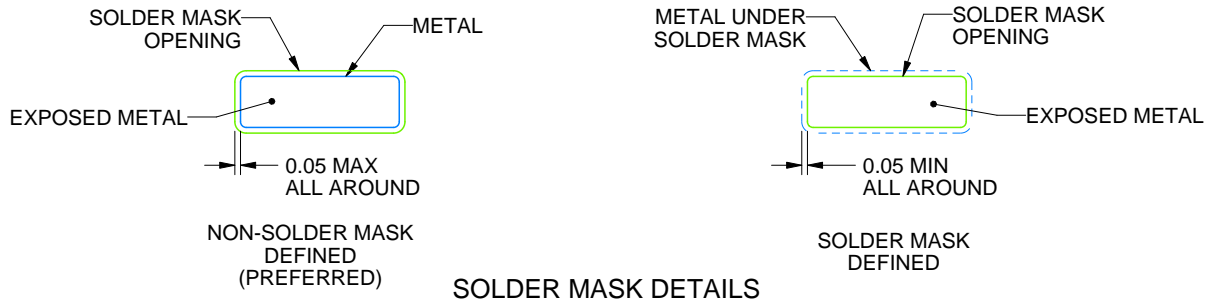
DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

EXAMPLE STENCIL DESIGN

DGK0008A

TM VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.



D0014A

PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4220718/A 09/2016

NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
5. Reference JEDEC registration MS-012, variation AB.

EXAMPLE BOARD LAYOUT

D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS

4220718/A 09/2016

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:8X

4220718/A 09/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



D0008A

PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed $.006$ [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
 EXPOSED METAL SHOWN
 SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



4220202/B 12/2023

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4220202/B 12/2023

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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